

Notice of References Cited	Application/Control No. 10/530,677		Applicant(s)/Patent Under Reexamination YOSHINO ET AL.	
	Examiner Anca Eoff		Art Unit 1795	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0009428	01-2004	Tamura et al.	430/280.1
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	N	WO 03/005126	01-2003		Tamura, K. et al.	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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